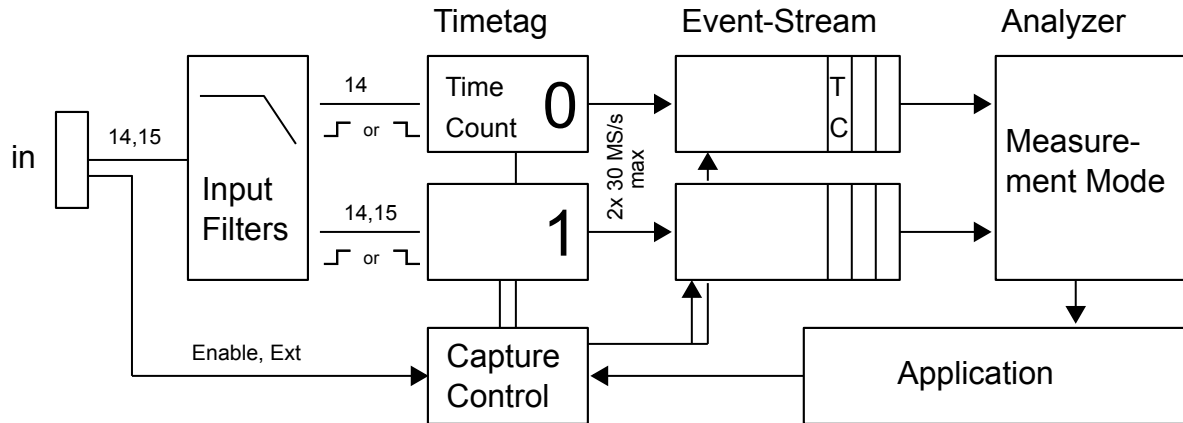


## 1 Overview

**Figure 1: Timing Analyzer Architecture**



The TIC-8420 system is shown in Figure 1. After optionally low-pass filtering the inputs, the Timetag unit continuously counts edges and records the time of their appearance. At the same time, the Capture Control unit decides when to capture a count-time pair (event) into the Event-Stream.

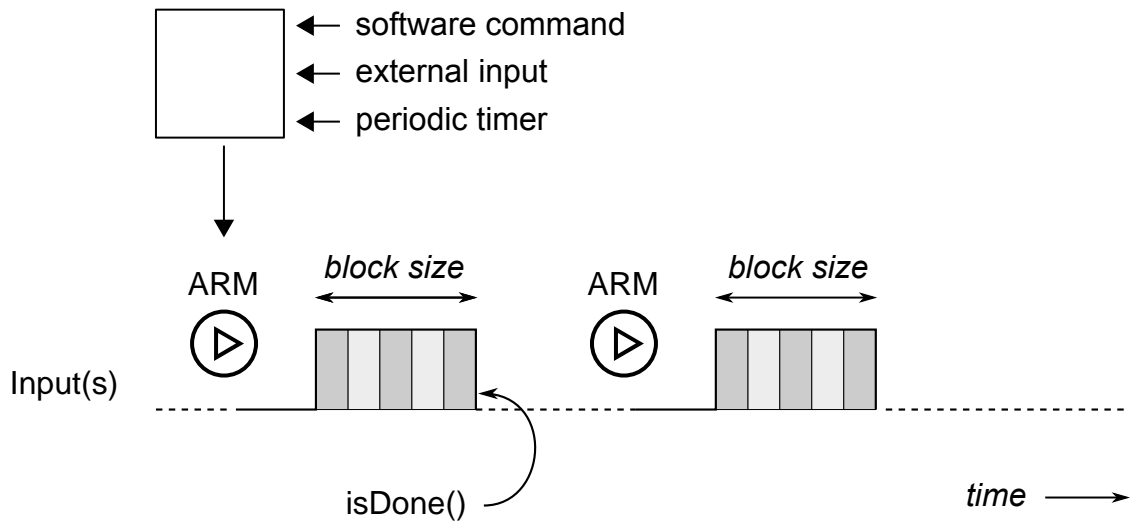
The Analyzer functions consume the events from the Event-Stream in order to provide measurement results to the application program.

Due to the continuous event streaming architecture all measurements can be made on a zero-dead-time basis (back to back) without loss of data. Within the limits of bus speed (USB/PCI) events may be logged continuously.



An IMPORTANT NOTICE at the end of this document addresses availability, warranty, changes, use in safety-critical applications, intellectual property matters and other important disclaimers.



**Figure 2: Arming for Measurements**

In any mode, the acquisition of timing data begins with the ARM signal. The ARM signal can be given “on-demand” by software control, external pulse, or on periodic timer intervals (Figure 2).

### Block size

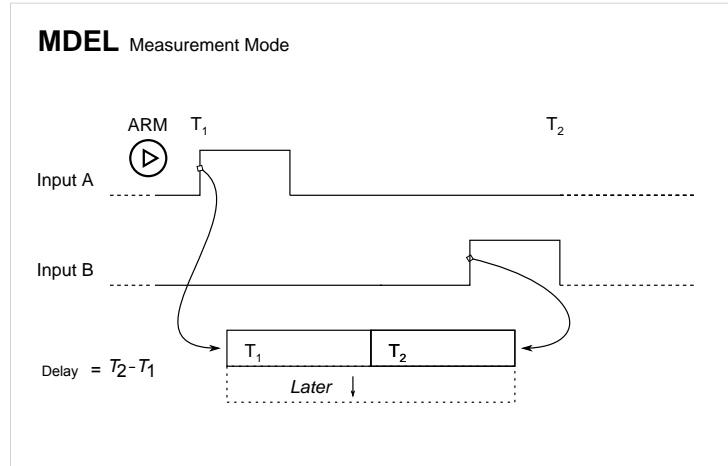
Per ARM block a pre-defined count of measurements can be taken. The default count is 1, for a single measurement per ARM pulse. Setting the block size to zero results in continuously taken measurements started at a single ARM pulse.

## 2 Measurement Modes

### 2.1 MDEL - Delay (Start/Stop)

Delay is the time difference between the activation of the A and B channel. The delay is positive if the A channel is activated prior to the B channel. The delay is zero if the A and B channel are activated at the same time. The delay is negative if the B channel is activated prior the the A channel.

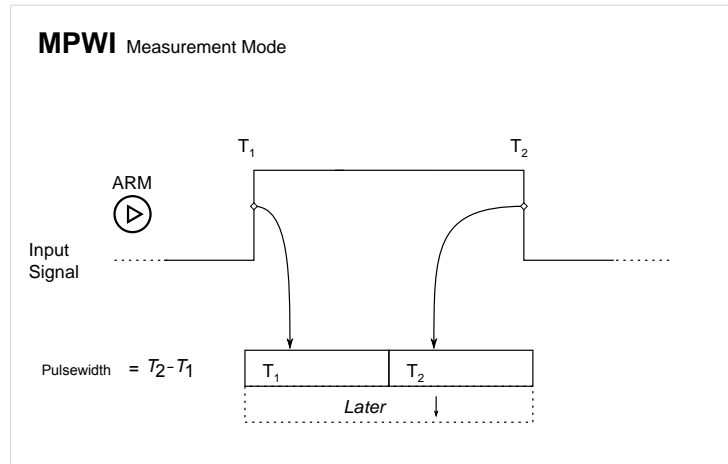
MDEL is activated via class [ModeDelay](#). The [tic\\_delay](#) example demonstrates how to use this mode in an application program.



### 2.2 MPWI - Pulse Width

In positive edge mode, pulse width is the distance between the low-to-high and the subsequent high-to-low edge of a pulse. In negative edge mode, pulse width is the distance between the high-to-low and the subsequent low-to-high edge of a pulse. By definition, pulse width is always a non-zero positive value.

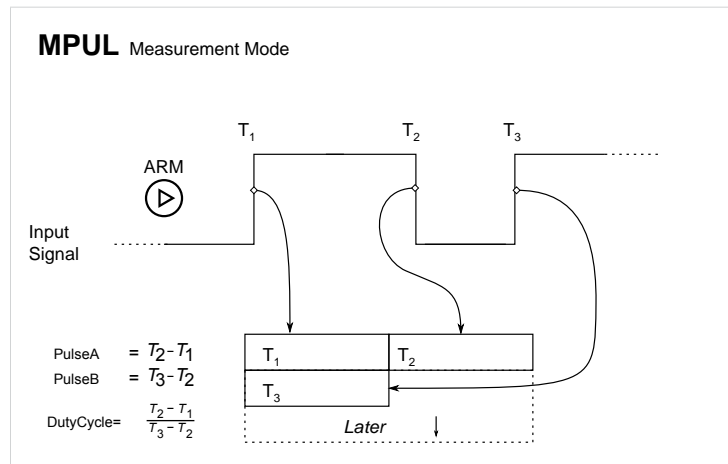
MPWI is activated via class [ModePulseWidth](#). The [tic\\_pulsewidth](#) example demonstrates how to use this mode in an application program.



### 2.3 MPUL - Pulse

This mode measures the active as well as the inactive time of a pulse. The pulse period and the duty cycle are calculated. In positive edge mode, the measurement starts with the low-to-high edge of the input signal. In negative edge mode, the measurement starts with the high-to-low edge of the input signal. The duty cycle is the ratio between the first and the second half of the pulse. By definition, the duty cycle may approach but never reach the value of 0 or 1.

MPUL is activated via class [ModePulse](#). The [tic\\_pulse](#) example demonstrates how to use this mode in an application program.



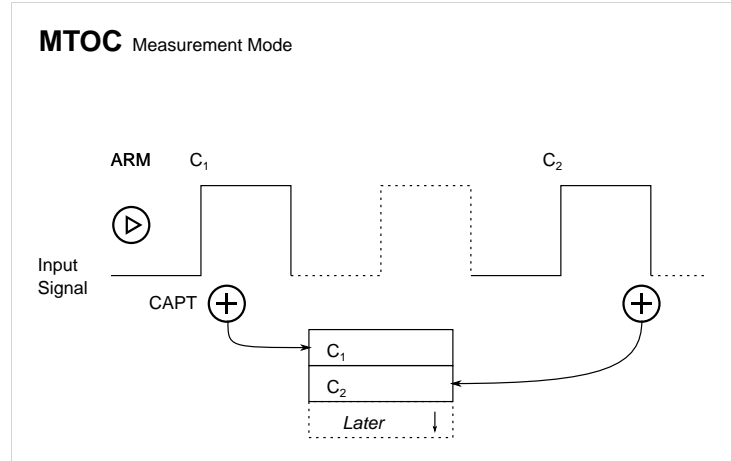
## 2.4 MTOC - Totalizing Counter

In totalizing counter mode, the Timetag unit continuously counts the active edges of the input signal. Only on a CAPT internal pulse, the event is captured. The CAPT signal can be given “on-demand” by software control, external pulse, or on periodic timer intervals. The counter's values along with the respective capture times are available from the analyzer.

In positive edge mode, the low-to-high edges of the input signal are counted. In negative edge mode, the high-to-low edges of the input signal are counted.

MTOC is activated via class [ModeTotalCount](#). The [tic\\_totalcount](#) example demonstrates how to use this mode in an application program.

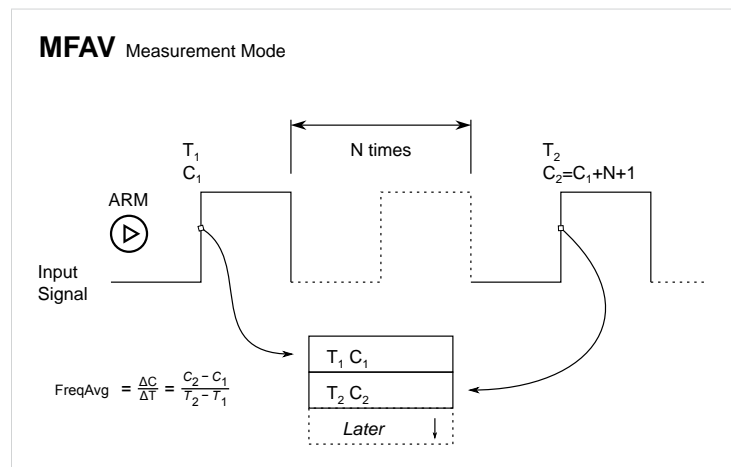
Note that, while this mode combined with periodic capture is able to provide frequency/period average measurements, a more precise, dedicated mode MFAV is provided (see below).



## 2.5 MFAV - Frequency Average

For frequency/period average measurements an interval  $N$  must be selected. An event is captured for every  $N$ th leading signal edge. The selection of  $N$  affects measurement time and resolution, see Section 4.

MFAV is activated via class [ModeAvg](#). The [tic\\_freq](#) example demonstrates how to use this mode in an application program.



### 3 Input Filters

The TIC-8420 provides low-pass (debouncing) filters at each digital input. The filter setting for each input can be configured independently. The table lists the Filter code to set the filter by the application program, the pulse width guaranteed to pass the filter ( $T_{\text{pass}}$ ), the pulse width guaranteed to not pass the filter ( $T_{\text{glitch}}$ ), and the maximum frequency able to pass the filter ( $f_{\text{max}}$ ).

**Input Filters**

Code	$T_{\text{pass}}$	$T_{\text{glitch}}$	$f_{\text{max}}$
0	2.78 ns	(unfiltered)	180 MHz
31	5.56 ns	2.78 ns	90.0 MHz
33	11.1 ns	5.56 ns	45.0 MHz
35	22.2 ns	11.1 ns	22.5 MHz
37	44.4 ns	22.2 ns	11.3 MHz
8	200 ns	167 ns	2.50 MHz
9	400 ns	333 ns	1.25 MHz
10	800 ns	667 ns	625 kHz
11	1.60 $\mu\text{s}$	1.33 $\mu\text{s}$	313 kHz
12	3.20 $\mu\text{s}$	2.67 $\mu\text{s}$	156 kHz
13	6.40 $\mu\text{s}$	5.33 $\mu\text{s}$	78.1 kHz
14	12.8 $\mu\text{s}$	10.7 $\mu\text{s}$	39.1 kHz
15	25.6 $\mu\text{s}$	21.3 $\mu\text{s}$	19.5 kHz
16	51.2 $\mu\text{s}$	42.7 $\mu\text{s}$	9.77 kHz
17	102 $\mu\text{s}$	85.3 $\mu\text{s}$	4.88 kHz
18	205 $\mu\text{s}$	171 $\mu\text{s}$	2.44 kHz
19	410 $\mu\text{s}$	341 $\mu\text{s}$	1.22 kHz
20	819 $\mu\text{s}$	683 $\mu\text{s}$	610 Hz
21	1.64 ms	1.37 ms	305 Hz
22	3.28 ms	2.37 ms	153 Hz
23	6.55 ms	5.46 ms	76.3 Hz
24	13.1 ms	10.9 ms	38.1 Hz

## 4 Measurement Resolution

The measurement resolution (the number of significant digits of the result) depends on the measurement time only. For example, a pulse of 2.8 $\mu$ s cannot be measured with more than 3 decimal digits resolution by the TIC-8420, whereas a pulse of 2.8ms is measured with 6 digits.

While the resolution is determined by the input signal in most modes, the frequency/period average mode MFAV allows to trade off measurement time against resolution. This is done by selecting a larger  $N$  to increase resolution (along with measurement time). To speed up measurements,  $N$  must be decreased at the cost of resolution.

Sign.	Measurement	Sample Freq	Range
2 ½	0.56 $\mu$ s	1.79 MHz	200
3	2.8 $\mu$ s	359 kHz	1 k
3 ½	5.6 $\mu$ s	178 kHz	2 k
4	28 $\mu$ s	35.9 kHz	10 k
4 ½	56 $\mu$ s	17.8 kHz	20 k
5	280 $\mu$ s	3.59 kHz	100 k
5 ½	560 $\mu$ s	1.78 kHz	200 k
6	2.8 ms	359 Hz	1 M
6 ½	5.6 ms	178 Hz	2 M
7	28 ms	35.9 Hz	10 M
7 ½	56 ms	17.8 Hz	20 M
8	280 ms	3.59 Hz	100 M
8 ½	560 ms	1.78 Hz	200 M
9	2.78 s	0.359 Hz	1 G

## 5 Programming

The interface to the instrument's hardware is implemented by class [TinaPlex](#). A separate instance of class TinaPlex is used per timing analyzer connected.

### Initialization

The measurement task which is represented by the [TinaMode](#) based object must be configured by calling the [callTinaConfig\(\)](#) function call. If the measurement is to be armed by software control (i.e. not externally or timer based) [callTinaArm\(\)](#) must be called.

### Transfer Loop

The transfer loop transfers raw measurement data from the instruments hardware to the analyzer functions implemented in software. The transfer loop must be operated as long as measurements are required. Within the transfer loop [callTinaSample\(\)](#) is called.

## 6 Connecting External Signals

The list explains the input signals to the TIC-8420. GND is the ground-reference for all lines. For input characteristics see Figure 8.

IN-A/B	The input waveform signal. For MDEL measurement the start signal is connected to IN-A, the stop signal to IN-B.
EN-A/B	The input enable signal if external enable is selected. Ignored if external enable is not selected.
ARM-A/B	The arm signal if external arm is selected. Ignored if external arm is not selected.
CAPT-A/B	The external capture signal if external capture is selected. Ignored if external capture is not selected.

**TIC-8420 Signal by Pin**

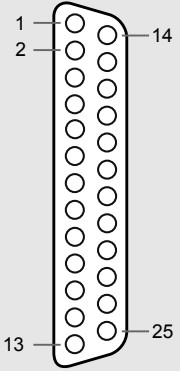
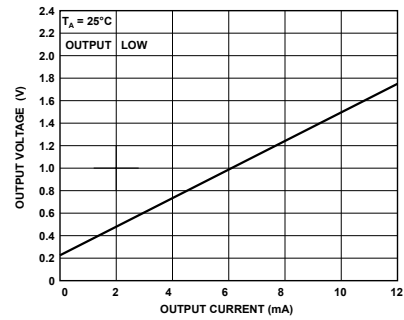
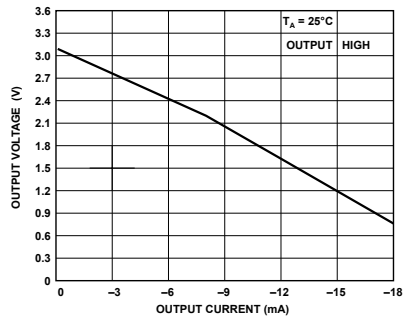
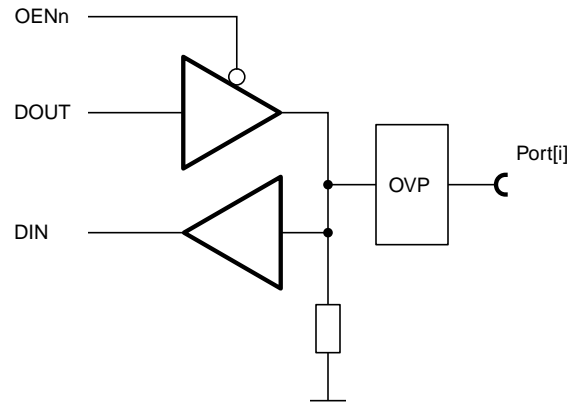
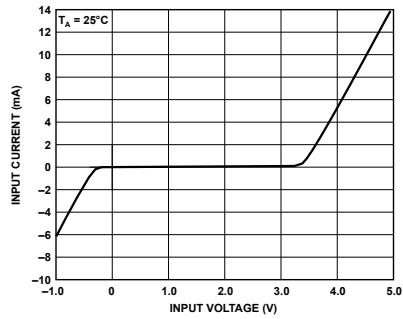
Signal	Pin	Connector View	Pin	Signal
3,3V	1		14	GND
IN-A/IO15	2		15	IN-B/IO14
GND	3		16	EN-B/IO13
EN-A/IO12	4		17	GND
ARM-B/IO11	5		18	ARM-A/IO10
GND	6		19	CAPT-B/IO09
CAPT-A/IO08	7		20	GND
IO07	8		21	IO06
GND	9		22	IO05
IO04	10		23	GND
IO03	11		24	IO02
GND	12		25	IO01
IO00	13			



Figure 8: I/O Characteristics



## Important Notice

No references to the C++ API documentation are available in this standalone version of the manual. In order to access the C++ API documentation download and install the complete driver software package.

### Trademarks

Product, service, or company names used in this document are for identification purposes only and may be either trademarks or registered trademarks of the relevant trademark owners. LabView, NI-488.2, LabWindows, PXI, DASyLab, DIAdem are trademarks or registered trademarks of National Instruments Corp., USA, in the United States and/or other countries. Microsoft, Windows, Windows NT, Windows CE, Windows 2000, Windows ME, Windows XP, Windows Vista, Visual Basic, Visual-C++ are trademarks or registered trademarks of Microsoft Corporation in the United States and/or other countries.

### Specifications

All specifications are subject to change without prior notice.

### Limited warranty and liability

Information in this document is believed to be accurate and reliable. However, Ines does not give any representations or warranties, expressed or implied, as to the accuracy or completeness of such information and shall have no liability for the consequences of use of such information. Ines takes no responsibility for the content in this document if provided by an information source outside of Ines. In no event shall Ines be liable for any indirect, incidental, punitive, special or consequential damages (including - without limitation - lost profits, lost savings, business interruption, costs related to the removal or replacement of any products or rework charges) whether or not such damages are based on tort (including negligence), warranty, breach of contract or any other legal theory. Notwithstanding any damages that customer might incur for any reason whatsoever, Ines' aggregate and cumulative liability towards customer for the products described herein shall be limited in accordance with the Terms and conditions of commercial sale of Ines.

### Software

ALL SOFTWARE IS PROVIDED "AS IS", WITHOUT WARRANTY OF ANY KIND, EXPRESS OR IMPLIED, INCLUDING BUT NOT LIMITED TO THE WARRANTIES OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE AND NON-INFRINGEMENT. IN NO EVENT SHALL THE AUTHORS OR COPYRIGHT HOLDERS BE LIABLE FOR ANY CLAIM, DAMAGES OR OTHER LIABILITY, WHETHER IN AN ACTION OF CONTRACT, TORT OR OTHERWISE, ARISING FROM, OUT OF OR IN CONNECTION WITH THE SOFTWARE OR THE USE OR OTHER DEALINGS IN THE SOFTWARE.